STRIPPING OF HIGH INTENSITY HEAVY-ION BEAMS IN A PULSED GAS STRIPPER DEVICE AT 1.4 MeV/u

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Abstract

As part of an injector system for FAIR, the GSI UNILAC has to meet high demands in terms of beam brilliance at a low duty factor. To accomplish this goal an extensive upgrade program has started.

To increase the beam intensity behind the UNILAC, it is aimed to increase the efficiency of the 1.4 MeV/u gas stripper. A modification of the stripper setup was developed to replace the N_2 -jet with a pulsed gas injection, synchronized with the transit of the beam pulse. The pulsed gas injection lowers the gas load for the differential pumping system, rendering possible the use of other promising gas targets.

In recent measurements the performance of the modified setup was tested using an 238 U-beam with various stripper media, including H₂, He, and N₂. The data provide a systematic basis for an improved understanding of slow heavy ions passing through gaseous media. The stripping performance of the current N₂-jet was excelled by using H₂ at increased gas densities, enabled by the new pulsed gas cell.

INTRODUCTION

The GSI UNIversal LInear ACcelerator (UNILAC) will serve as part of an injector system for the future Facility for Antiproton and Ion Research (FAIR), currently under construction at GSI in Darmstadt, Germany. Therefore it has to meet high demands in terms of beam brilliance at a very low duty cycle (100 μ s beam pulse length, 2.7 Hz repetition rate) [1]. To achieve this goal, an extensive upgrade program of the UNILAC has been started [2].

After acceleration in the UNILAC High Current Injector the ion beams are passing a gas stripper section at 1.4 MeV/u. The ions are stripped of electrons and the charge state of the ion beam is increased. After stripping, a charge state distribution results, and charge separation is accomplished by a system of dipole magnets; thus, only ions with the desired charge state are selected for further acceleration. The current gas stripper uses a laval nozzle at a back-pressure of 0.4 MPa to apply a super-sonic N₂-jet [3].

A key projectile for FAIR is 238 U [1]. In the gas stripper, the charge state of the U-ions is increased from 4^+ , with 28^+ being needed for further acceleration. Measurements with the N₂-jet show equilibrated charge state distributions for U on N₂ with an average charge state between 26^+ and 27^+ [4]. To increase the stripping efficiency into the desired charge state (28^+) , the use of other stripper gases is explored. To use other promising stripper gases at sufficient gas density, the back-pressure on the gas inlet has to be increased. The limitations of the differential pumping system connecting the stripper to the accelerator hinder this approach using the laval nozzle [5].

For working with increased gas density with the current pumping setup, the laval nozzle was exchanged by a pulsed valve, which is the basis for a pulsed gas cell. The valve opens only when a beam pulse passes the gas stripper and closes immediately afterwards. Given the low beam duty cycle, this enables the use of much higher back-pressures on the gas inlet, which is assumed to lead to higher gas densities in the interaction zone. With this modified setup, the use of other stripper gases at sufficient gas densities appears possible.

The new modified setup was first tested early in 2014 with a Bi-beam using N_2 as a stripper gas [6]. Recently, another measurement series was conducted using an U-beam on H_2 , He and N_2 and a yet improved setup.

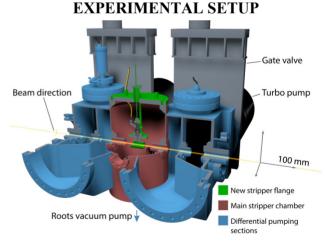


Figure 1: 3D model of the GSI UNILAC gas stripper.

The experimental setup that was used for these measurements is a modified version of the setup described in [6]. The basic parts of the GSI UNILAC gas stripper are depicted in Fig. 1. A four stage differential pumping system is used to achieve the required vacuum in the adjacent accelerator line. The major gas load is removed by a roots vacuum pump (2222 l/s) located directly below the main stripper chamber. The adjacent

and stages of the differential pumping system are pumped down by four turbo pumps (1200 l/s each).

ublisher. The flange on top of the main chamber was exchanged for a newly developed flange, featuring the pulsed gas valve. A 3D model of the new flange is shown in Fig. 2. work. The valve outlet is located very close to the beam trajectory, inside the main stripper chamber. The gas of the enters a T-fitting, aligned with the beam axis, which g prevents instantaneous exhaustion of the gas through the roots vacuum nume. The line of a roots vacuum pump. The length of the T-fitting in beam axis is 44 mm and can be varied; the aperture is 21 mm.

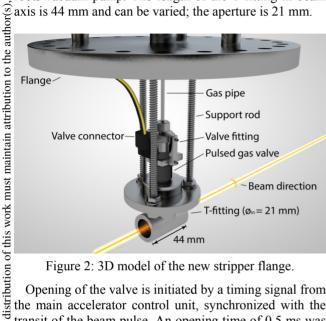


Figure 2: 3D model of the new stripper flange.

Opening of the valve is initiated by a timing signal from the main accelerator control unit, synchronized with the transit of the beam pulse. An opening time of 0.5 ms was We used for the measurements.

Gas is supplied from standard 2 MPa gas bottles with a 3 \overline{c} pressure regulator. For the measurements with H₂, a \bigcirc specially designed safety valve system was used.

The beam current was measured using beam transformers in front of and behind the stripper. A dipole magnet directly after the stripper section enables charge in state separation of the beam. A slit system allows \succeq selecting only the desired charge state. Charge states below 21⁺ could not be measured because of the fieldstrength limitations of the dipole magnet. he

The beam emittance was measured using a slit-grid of system, as described in [7], and it is located behind the erms charge separation system. The energy-loss of the beam in the gas was determined from time of flight measurements using phase probes along the accelerator line.

under To compare the stripping performance of the new setup with that of the N₂-jet stripper, additional measurements used were conducted using the stripper flange with the laval 2 nozzle. For all measurements, a high-current ²³⁸U⁴⁺-beam

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evolution of the beam current was observed until saturation was reached.

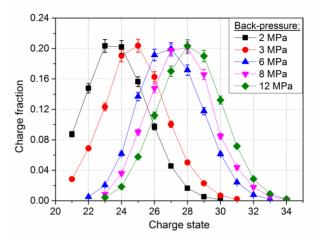


Figure 3: Charge state distribution for U on H_2 with increasing back-pressure on the gas inlet.

For N₂ and He, equilibrated charge spectra were measured within the applied pressure range. For H₂, an equilibrated charge state distribution could not be obtained, cf. Fig. 3. The back-pressure was increased from 2 MPa to 12 MPa. The average charge state increased from about 23^+ at 2 MPa to about 28^+ at 12 MPa. The width of the distribution remained the same within the uncertainty range. From the trend of the charge state evolution, saturation at a back-pressure of about 18 MPa is expected. As only charge states above 21^+ could be measured, the charge state distributions for 2 MPa and 3 MPa were normalized to the maximum charge fraction, which was determined absolutely.

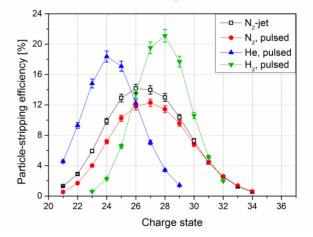


Figure 4: Measured stripping efficiencies for U on H₂, He and N₂ using the pulsed gas cell (full symbols) and the N_2 -jet (open symbols); all distributions except for H_2 are equilibrated, suggesting that even higher charge states can be populated with H₂ at higher gas densities. Lower efficiencies for pulsed N2 compared to the N2-jet are caused by decreased transmission.

To compare stripping performances, the stripping efficiency, which is the fraction of ions in a specific

> 4: Hadron Accelerators T32 - Ion Beam Stripping

charge state in relation to the total number of ions in front of the stripper, was measured for the equilibrated charge state distributions with the N₂-jet and He, N₂ (all saturated) and H₂, at 12 MPa (not saturated), using the pulsed gas cell. The stripping efficiencies were measured separately for each charge state and are depicted in Fig. 4.

The comparison of N_2 (pulsed) with the N₂-jet shows overall lower stripping efficiencies at a similar average charge state. The transmission for N₂ (pulsed) is 85 % compared to 100 % transmission with the N₂-jet. For H₂, the transmission is 99 %. The error in the transmission measurement is ± 4 %.

The charge state distributions for He and H₂ are more narrow than for N₂. This was expected for low-Z gases as it was observed before. The narrow charge state distributions result in higher stripping efficiencies for the dominantly populated charge states. The equilibrated average charge state for He is about 24⁺, which is insufficient to reach desireable U²⁸⁺-intensities. For H₂, the highest measured average charge state at 12 MPa is about 28⁺.

Table 1: Comparison of the Stripper Performance for a High-current U-beam Using the $N_2\mbox{-jet}$ and the Pulsed H_2 Gas Cell.

	N ₂ -jet	H ₂ , pulsed
Back-pressure	0.4 MPa	8 MPa
Maximum charge state	+26	+27
Particle-stripping efficiency into 28 ⁺	12.7(5) %	20.1(8) %
Energy-loss	20(5) keV/u	12(5) keV/u
Estimated thickness	44.9 µg/cm ²	9.3 μg/cm ²
Maximum U ²⁸⁺ -current	4.5 emA	7.8 emA
ϵ_x (90%, total) norm.	0.76(2) µm	0.70(1) μm
ϵ_y (90%, total) norm.	0.84(2) µm	0.93(2) μm
Beam brilliance $(28^+, X)$	5.32 mA/µm	10.03 mA/µm
Beam brilliance $(28^+, Y)$	4.82 mA/µm	7.55 mA/µm

A comparison of the new pulsed H₂ gas cell (8 MPa) and the N₂-jet is shown in Table. 1 (for more details, see [8]). Due to the narrow charge state distribution and the increased average charge state with the pulsed H₂ gas cell, the stripping efficiency into the 28⁺ charge state is increased significantly, resulting in an increased U²⁸⁺ beam current. An energy-loss of 20 \pm 5 keV/u was measured for the N₂-jet, while it was 12 \pm 5 keV/u for the pulsed gas cell with H₂ at 12 MPa back-pressure. The shown thicknesses were estimated from the measured energy-losses using LISE++ [9].

The beam emittance was measured in vertical and horizontal axis for the pulsed H_2 gas cell and compared to the N_2 -jet. The horizontal beam emittance for the pulsed H_2 gas cell is slightly smaller than that of the N_2 -jet; the

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vertical beam emittance is slightly increased. The evaluated horizontal and vertical beam brilliance is increased significantly by using the pulsed H_2 gas cell.

CONCLUSIONS AND OUTLOOK

Charge state distributions of U beams after interaction with a variety of gases was measured, and the full results will be given in [10]. Here, we point out that for application, e.g., at the UNILAC, the measurements show especially promising results for the electron stripping of U with H₂. The stripping efficiency for the desired 28⁺ charge state could be increased from 12.7 % using the N₂jet stripper to 20.1 % using the new pulsed gas cell with H₂ at 8 MPa back-pressure. The beam brilliance was significantly increased with the pulsed H₂ gas cell.

The measurements of the charge state distribution of H_2 indicate the possibility to achieve even higher average charge states if the gas density can be increased further. For this, an advanced setup with multiple gas valves, certified for higher back-pressures, is under construction. In separate off-line measurements the effective gas density of the pulsed gas cell will be measured.

The measurements with N_2 (pulsed) show a decrease of the transmission through the stripper, which is in agreement with earlier results obtained with a Bi-beam [6]. This may be caused by a non-optimized focusing of the beam with the new pulsed gas cell and will be investigated in future measurements.

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